


<b>Search Notes</b> 	<b>Application/Control No.</b> 10562115	<b>Applicant(s)/Patent Under Reexamination</b> SAKURAI ET AL.
	<b>Examiner</b> David K O'Dell	<b>Art Unit</b> 1625

SEARCHED			
Class	Subclass	Date	Examiner
548	508	3/16/2009	dko

SEARCH NOTES		
Search Notes	Date	Examiner
STN, EAST, PALM	3/16/2009	dko

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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